1200 V, 50 A Fast Field-Stop IGBT 7 with SiC Diode

APT50GH120BSC20



Product Overview

1200 V, 50 A Fast Field-Stop IGBT with co-packaged, anti-parallel SiC diode, TO-247

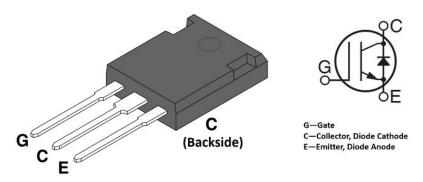


Table 1. Ordering Information

Catalog Part Number (CPN)	Package	Packing Media	Qualification
APT50GH120BSC20	TO-247	Tube	Industrial

Features

- Low conduction loss and saturation voltage
- Fast switching
- · Low gate charge
- · Ultrafast tail current shutoff
- No reverse recovery
- · Reverse-bias safe operating area (RBSOA) rated
- Easy to parallel
- · RoHS compliant
- Zero E_{on} switching loss from co-packaged, anti-parallel diode

1. Device Specifications: IGBT

This section shows the specifications of this device.

1.1. Absolute Maximum Ratings

The following table shows the absolute maximum ratings of this device. $T_C = 25$ °C unless otherwise specified.

Table 1-1. Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
V_{CES}	Collector-emitter voltage	1200	٧
V_{GE}	Gate-emitter voltage	±20	
I _{C1}	Continuous collector current ¹ (T _C = 25 °C)	119	Α
I _{C2}	Continuous collector current ¹ (T _C = 100 °C)	73	
I _{CM}	Pulsed collector current ² (T _C = 175 °C)	200	
RBSOA	Reverse-bias safe operating area (T _J = 150 °C, 960 V)	200	А
P_{D}	Total power dissipation	492	W

Notes:

- 1. Limited by maximum lead temperature.
- 2. Repetitive rating: Pulse width and case temperature are limited by the maximum junction temperature.

1.2. Thermal and Mechanical Characteristics

The following table shows the thermal and mechanical characteristics of this device.

Table 1-2. Thermal and Mechanical Characteristics

Symbol	Characteristic	Min.	Тур.	Max.	Unit
$R_{\Theta JC}$	Junction-to-case thermal resistance (IGBT)		0.21	0.31	°C/W
	Junction-to-case thermal resistance (diode)		0.65	0.95	
T _J , T _{STG}	Operating and storage junction temperature	-40		175	°C
T_{L}	Lead temperature for 10 seconds			300	
τ_{M}	Mounting torque, M3 screw for heat sink attachment (requires 1, not included)		0.8		N·m
Wt	Package weight		6.2		g

1.3. Electrical Performance

The following table shows the static characteristics of this device. T_C = 25 °C unless otherwise specified.

Table 1-3. Static Characteristics

Symbol	Characteristic	Test Conditions	Min.	Тур.	Max.	Unit
V _{GE(th)}	Gate threshold voltage	$V_{CE} = V_{GE}$, $I_{C} = 0.8 \text{ mA}$	4.7	5.5	6.2	٧
V _{CE(ON)}	Collector-emitter on voltage	$V_{GE} = 15 \text{ V}, I_{C} = 50 \text{ A}$		1.7	2.15	
		V _{GE} = 15 V, I _C = 50 A, T _J = 175 °C		2.1		
I _{CES}	Collector cut-off current ¹	V _{CE} = 1200 V, V _{GE} = 0 V			240	μΑ
		V _{CE} = 1200 V, V _{GE} = 0 V, T _J = 175 °C		3600		
I _{GES}	Gate-emitter leakage current	V _{GE} = ±20 V			±100	nA



Note:

1. I_{CES} includes both IGBT and diode leakages.

The following table shows the dynamic characteristics of this device. $T_C = 25$ °C unless otherwise specified.

Table 1-4. Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min.	Тур.	Max.	Unit
C _{ies}	Input capacitance	$V_{GE} = 0 \text{ V}, V_{CE} = 25 \text{ V}, f = 200 \text{ kHz}$		6885		pF
C _{res}	Reverse transfer capacitance			36		
C _{oes}	Output capacitance			95		
V_{GEP}	Gate-to-emitter plateau voltage	V_{GE} = 15 V, V_{CE} = 960 V, I_{C} = 50 A		7.5		٧
Q_{G}	Total gate charge ¹			375		nC
Q _{GE}	Gate-emitter charge			46		
Q_{GC}	Gate-collector ("Miller") charge			143		
RBSOA	Reverse-bias safe operating area	T_J = 175 °C, R_G = 23 Ω, V_{GE} = 15 V, V_{CE} = 800 V, L = 100 μH	200			A
t _{d(on)}	Turn-on delay time	$V_{CC} = 800 \text{ V}, V_{GE} = 15 \text{ V}, I_{C} = 50 \text{ A},$		22		ns
t _r	Current rise time	$R_G = 5 \Omega$, $T_J = 25 °C$		31		
t _{d(off)}	Turn-off delay time			222		
t _f	Current fall time			33		
E _{on}	Turn-on switching energy ²			2220		μJ
E _{off}	Turn-off switching energy ³			1470		
t _{d(on)}	Turn-on delay time	V_{CC} = 800 V, V_{GE} = 15 V, I_{C} = 50 A,		22		ns
t _r	Current rise time	$R_G = 5 \Omega$, $T_J = 175 °C$		31		
t _{d(off)}	Turn-off delay time			259		
t _f	Current fall time			51		
E _{on}	Turn-on switching energy ²			2300		μJ
E _{off}	Turn-off switching energy ³			2440		

Notes:

- 1. See MIL-STD-750 Method 3471.
- 2. E_{on} is the clamped inductive turn-on-energy of this device; there is no contribution to E_{on} from the SiC diode. (See Figure 1-19, Figure 1-20).
- 3. E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1. (See Figure 1-19, Figure 1-21.)

1.4. Typical Performance Curves

Data for performance curves are characterized, not 100% tested.

Figure 1-1. Output Characteristics

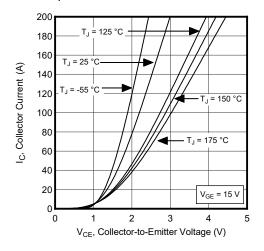


Figure 1-2. Transfer Characteristics

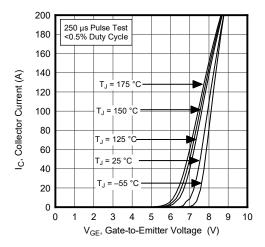


Figure 1-3. Gate Charge

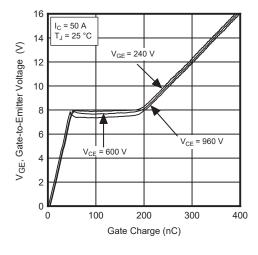


Figure 1-4. On-State Voltage vs. Gate-to-Emitter Voltage

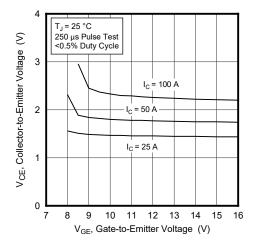


Figure 1-5. On-State Voltage vs. Junction Temperature

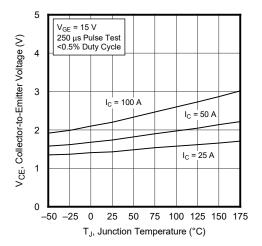


Figure 1-7. Turn-On Delay Time vs. Collector Current

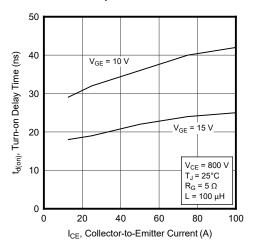


Figure 1-9. Current Rise Time vs. Collector Current

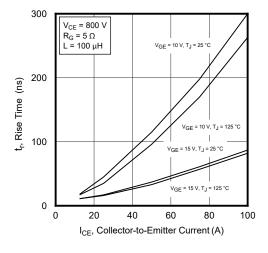


Figure 1-6. DC Collector Current vs. Case Temperature

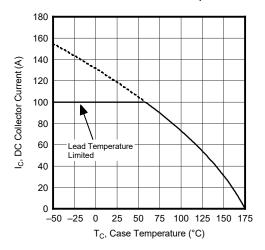


Figure 1-8. Turn-Off Delay Time vs. Collector Current

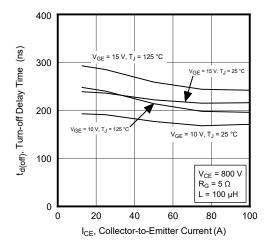


Figure 1-10. Current Fall Time vs. Collector Current

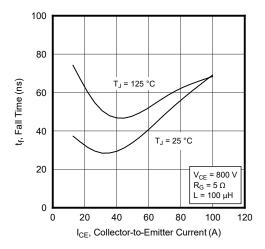


Figure 1-11. Turn-On Energy Loss vs. Collector Current

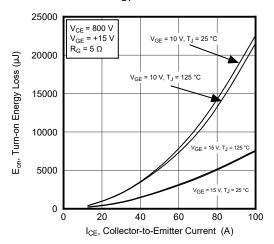
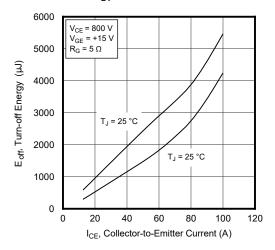


Figure 1-12. Turn-Off Energy Loss vs. Collector Current



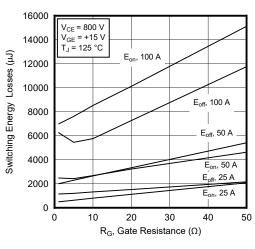


Figure 1-13. Switching Energy Losses vs. Gate Resistance Figure 1-14. Switching Energy Losses vs. Junction Temperature

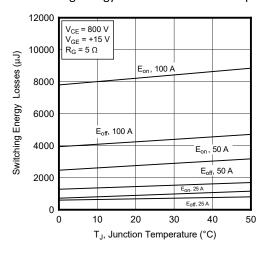
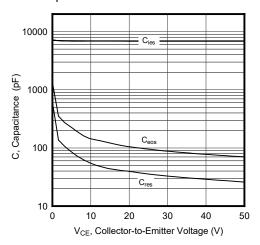


Figure 1-15. Capacitance vs. Collector-To-Emitter Voltage Figure 1-16. Reverse-bias Safe Operating Area



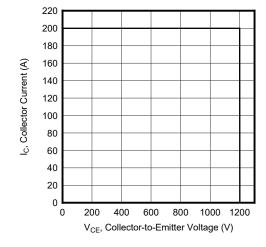


Figure 1-17. Maximum Transient Thermal Impedance

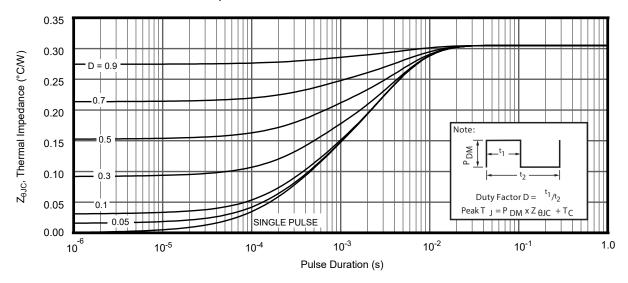


Figure 1-18. Transient Thermal Impedance Model

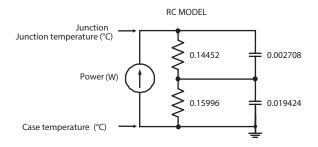


Figure 1-19. Inductive Switching Test Circuit

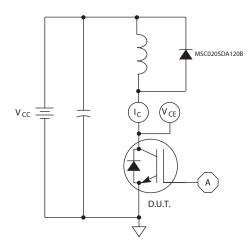


Figure 1-20. Turn-on Switching Waveform and Definitions

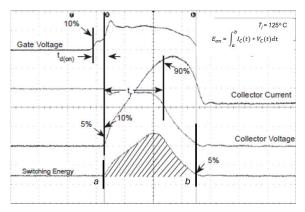
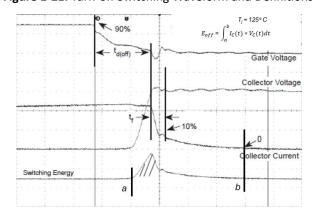


Figure 1-21. Turn-off Switching Waveform and Definitions





2. Device Specifications: Zero-Recovery SiC Anti-Parallel Diode

This section shows the specifications of the co-packaged, anti-parallel diode.

2.1. Absolute Maximum Ratings

The following table shows the absolute maximum ratings of the anti-parallel diode. $T_C = 25$ °C unless otherwise specified.

Table 2-1. Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
I _F	Maximum DC forward current (T _C = 25 °C)	49	Α
	Maximum DC forward current (T _C = 135 °C)	22	
	Maximum DC forward current (T _C = 145 °C)	18	
I _{FRM}	Repetitive peak forward surge current (t_p = 8.3 ms, half sine wave)	64	
I _{FSM}	Non-repetitive forward surge current (t_p = 8.3 ms, half sine wave)	115	
P _{TOT}	Total power dissipation (T _C = 25 °C)	186	W
	Total power dissipation (T _C = 110 °C)	80	

2.2. Electrical Performance

The following table shows the static characteristics of the anti-parallel diode.

Table 2-2. Static Characteristics

Symbol	Characteristic	Test Conditions	Min.	Тур.	Max.	Unit
V _F	Forward voltage	I _F = 20 A, T _C = 25 °C		1.5	1.8	V
		I _F = 20 A, T _C = 175 °C		2.0		

2.3. Typical Performance Curves

Data for performance curves are characterized, not 100% tested.

Figure 2-1. Maximum Transient Thermal Impedance

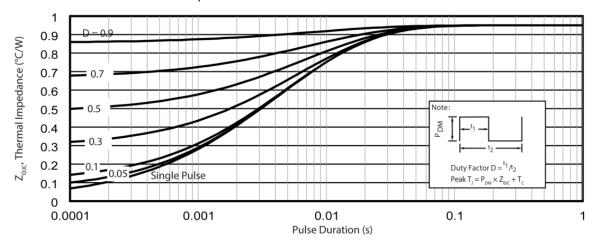




Figure 2-2. Forward Current vs. Forward Voltage

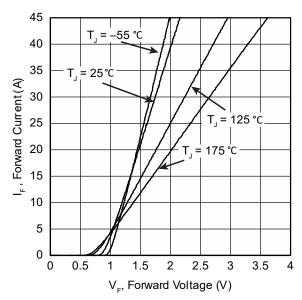


Figure 2-3. Max. Forward Current vs. Case Temp.

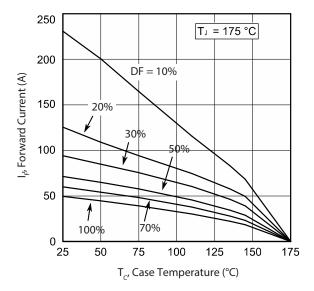


Figure 2-4. Max. Power Dissipation vs. Case Temp.

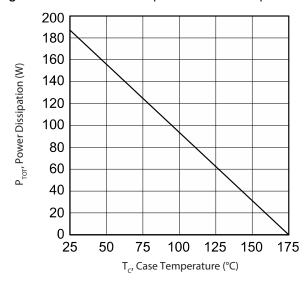
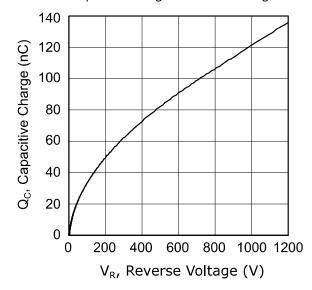


Figure 2-5. Total Capacitive Charge vs. Reverse Voltage





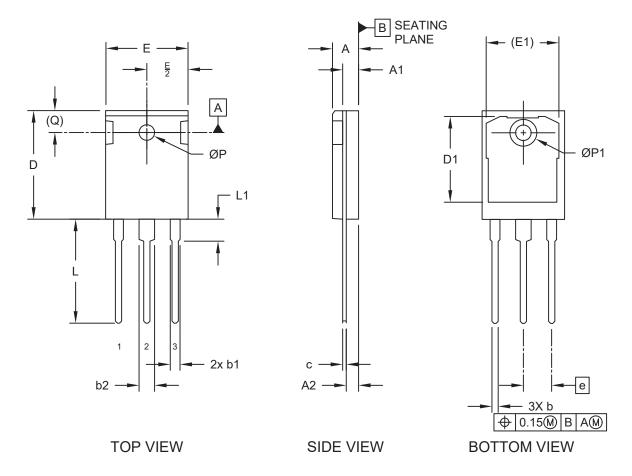
3. Package Specification

This section shows the package specification of this device.

3.1. Package Outline Drawing

The following figure illustrates the TO-247 package outline of this device.

Figure 3-1. Package Outline Drawing



The following table shows the TO-247 dimensions and should be used in conjunction with the package outline drawing.

Table 3-1. TO-247 Dimensions

Dimension Limits		Dimensions (mm)		
		Min.	Max.	
Number of leads	N		3	
Pitch	е	5.44	I BSC	
Overall height	A	4.70	5.31	
Tab height	A1	1.50	2.49	
Seating plane to lead	A2	2.21	2.59	
Lead width	b	1.02	1.40	
Lead shoulder width (×2)	b1	1.65	2.41	
Lead shoulder width	b2	2.87	3.38	



Table 3-1. TO-247 Dimensions (continued)				
Dimension Limits		Dimensions (mm)		
		Min.	Max.	
Lead thickness	С	0.41	0.79	
Lead length	L	19.81	20.32	
Lead shoulder length	L1	3.99	4.50	
Molded body length	D	20.80	21.46	
Thermal pad length	D1	16.25	17.65	
Total width	E	15.49	16.26	
Thermal pad width	E1	13.10	14.50	
Hole center to tab edge	Q	6.15	5 REF	
Hole diameter	ØP	3.51	3.81	
Thermal pad hole diameter	ØP1	7.18	3 REF	

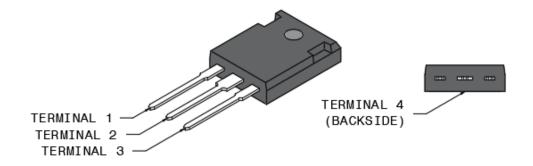
Notes: Dimensioning and tolerancing per ASME Y14.5M

- BSC: Basic dimension—Theoretically exact value shown without tolerances.
- REF: Reference dimension—Usually without tolerance, for information purposes only.

3.2. Terminal Pinout

The following figure illustrates the terminal pinout of this device.

Figure 3-2. Terminal Pinout



The following table shows the electrical signal terminal pinout of this device.

Table 3-2. Electrical Signal Terminal Pinout

Terminal	Definition
TERMINAL 1	Gate
TERMINAL 2	Collector, Diode Cathode
TERMINAL 3	Emitter, Diode Anode
TERMINAL 4	Collector, Diode Cathode



4. Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

Table 4-1. Revision History

Revision	Date	Description
В	08/2025	 Corrected data in IGBT Electrical Performance section. Updated select graphs in IGBT Typical Performance Curves section.
A	07/2025	Document created.



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ISBN: 979-8-3371-1753-9

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